# 74HC4017; 74HCT4017

# Johnson decade counter with 10 decoded outputs Rev. 4 — 10 December 2013 Produ

**Product data sheet** 

#### 1. **General description**

The 74HC4017; 74HCT4017 is a 5-stage Johnson decade counter with 10 decoded outputs (Q0 to Q9), an output from the most significant flip-flop (Q5-9), two clock inputs (CP0 and CP1) and an overriding asynchronous master reset input (MR). The counter is advanced by either a LOW-to-HIGH transition at CP0 while CP1 is LOW or a HIGH-to-LOW transition at  $\overline{\text{CP}}1$  while CP0 is HIGH. When cascading counters, the  $\overline{\text{Q}}5-9$ output, which is LOW while the counter is in states 5, 6, 7, 8 and 9, can be used to drive the CP0 input of the next counter. A HIGH on MR resets the counter to zero (Q0 =  $\overline{Q}$ 5-9 = HIGH; Q1 to Q9 = LOW) independent of the clock inputs (CP0 and CP1). Automatic code correction of the counter is provided by an internal circuit: following any illegal code the counter returns to a proper counting mode within 11 clock pulses. Inputs include clamp diodes. This enables the use of current limiting resistors to interface inputs to voltages in excess of V<sub>CC</sub>.

#### 2. **Features and benefits**

- Wide supply voltage range from 2.0 V to 6.0 V
- Input levels:
  - ◆ For 74HC4017: CMOS level
  - For 74HCT4017: TTL level
- Complies with JEDEC standard no. 7 A
- ESD protection:
  - ◆ HBM JESD22-A114E exceeds 2000 V
  - MM JESD22-A115-A exceeds 200 V
- Multiple package options
- Specified from -40 °C to +85 °C and from -40 °C to +125 °C

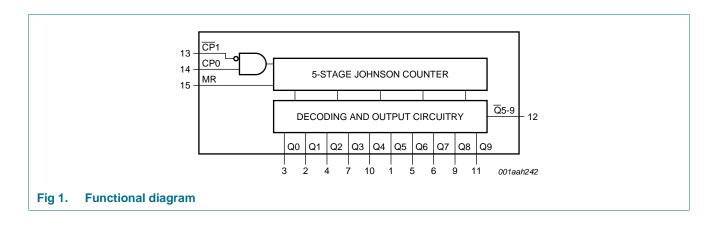


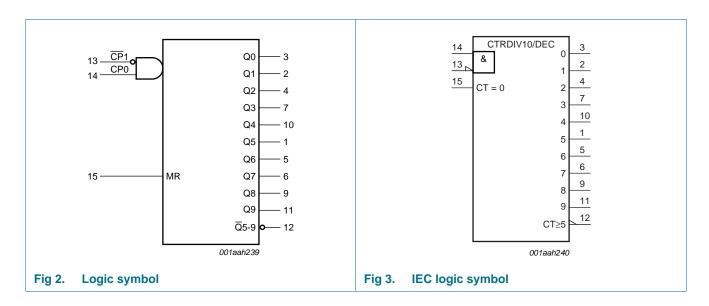
## 3. Ordering information

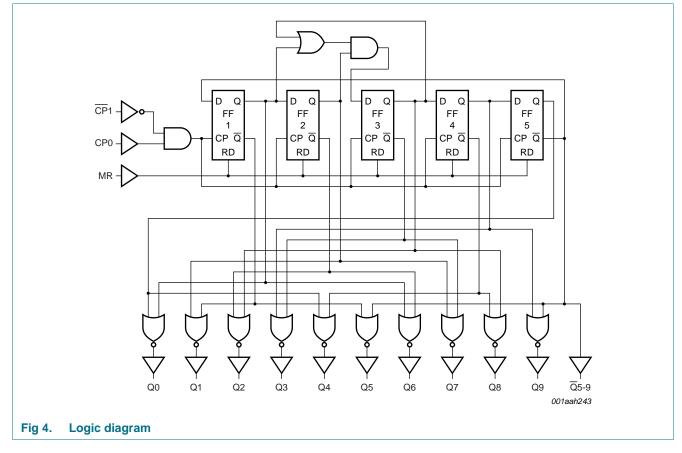
Table 1. Ordering information

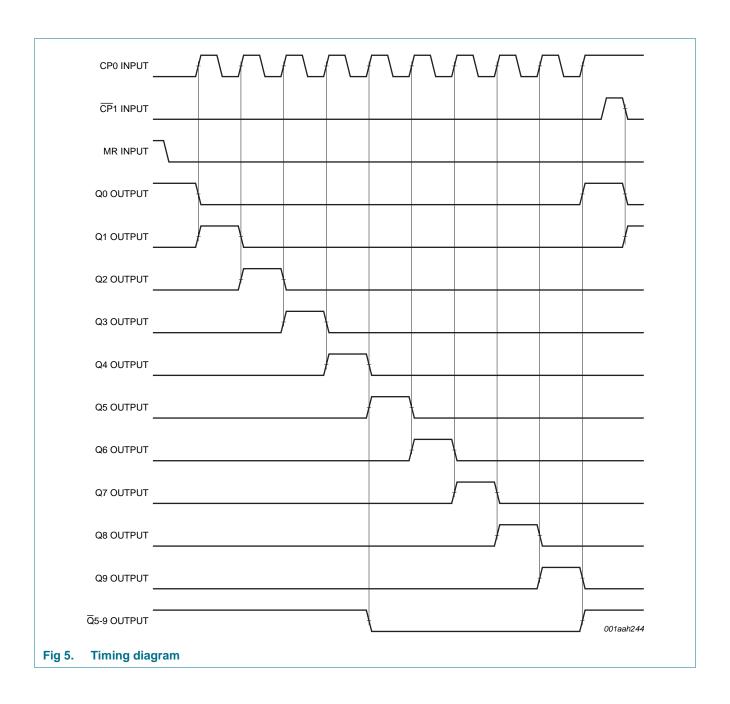
Type number	Package			
	Temperature range	Name	Description	Version
74HC4017	'			
74HC4017N	−40 °C to +125 °C	DIP16	plastic dual in-line package; 16 leads (300 mil)	SOT38-4
74HC4017D	–40 °C to +125 °C	SO16	plastic small outline package; 16 leads; body width 3.9 mm	SOT109-1
74HC4017DB	–40 °C to +125 °C	SSOP16	plastic shrink small outline package; 16 leads; body width 5.3 mm	SOT338-1
74HC4017PW	–40 °C to +125 °C	TSSOP16	plastic thin shrink small outline package; 16 leads; body width 4.4 mm	SOT403-1
74HC4017BQ	–40 °C to +125 °C	DHVQFN16	plastic dual in-line compatible thermal-enhanced very thin quad flat package; no leads; 16 terminals; body $2.5\times3.5\times0.85$ mm	SOT763-1
74HCT4017				
74HCT4017N	−40 °C to +125 °C	DIP16	plastic dual in-line package; 16 leads (300 mil)	SOT38-4
74HCT4017D	–40 °C to +125 °C	SO16	plastic small outline package; 16 leads; body width 3.9 mm	SOT109-1
74HCT4017BQ	–40 °C to +125 °C	DHVQFN16	plastic dual in-line compatible thermal-enhanced very thin quad flat package; no leads; 16 terminals; body $2.5\times3.5\times0.85$ mm	SOT763-1

## 4. Functional diagram



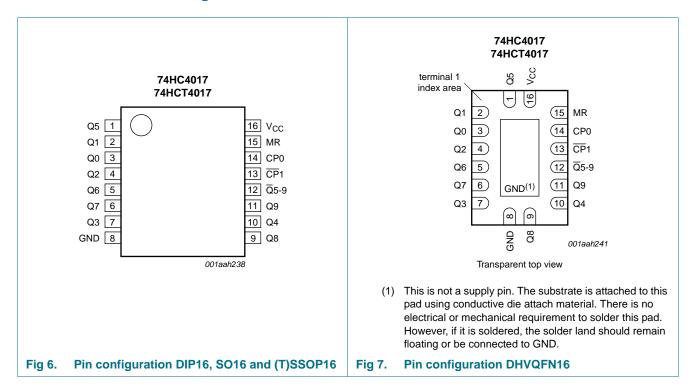






## 5. Pinning information

#### 5.1 Pinning



#### 5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
Q[0:9]	3, 2, 4, 7, 10, 1, 5, 6, 9, 11	decoded output
GND	8	ground (0 V)
<del>Q</del> 5-9	12	carry output (active LOW)
CP1	13	clock input (HIGH-to-LOW edge-triggered)
CP0	14	clock input (LOW-to-HIGH edge-triggered)
MR	15	master reset input (active HIGH)
V <sub>CC</sub>	16	supply voltage

## 6. Functional description

Table 3. Function table[1]

MR	CP0	CP1	Operation
Н	X	X	Q0 = $\overline{Q}$ 5-9 = HIGH; Q1 to Q9 = LOW
L	Н	<b>↓</b>	counter advances
L	<b>↑</b>	L	counter advances
L	L	X	no change
L	X	Н	no change
L	Н	<b>↑</b>	no change
L	<b>\</b>	L	no change

<sup>[1]</sup> H = HIGH voltage level;

## 7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CC}$	supply voltage		-0.5	+7	V
I <sub>IK</sub>	input clamping current	$V_I < -0.5 \text{ V or } V_I > V_{CC} + 0.5 \text{ V}$	<u>[1]</u> _	±20	mA
I <sub>OK</sub>	output clamping current	$V_O < -0.5 \text{ V or } V_O > V_{CC} + 0.5 \text{ V}$	<u>[1]</u> _	±20	mA
Io	output current	$-0.5 \text{ V} < \text{V}_{\text{O}} < \text{V}_{\text{CC}} + 0.5 \text{ V}$	-	±25	mA
I <sub>CC</sub>	supply current		-	50	mA
I <sub>GND</sub>	ground current		-50	-	mA
T <sub>stg</sub>	storage temperature		-65	+150	°C
P <sub>tot</sub>	total power dissipation	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } +125  ^{\circ}\text{C}$			
	DIP16 package		[2] _	750	mW
	SO16 package		[3] _	500	mW
	(T)SSOP16 package		<u>[4]</u> _	500	mW
	DHVQFN16 package		<u>[5]</u> _	500	mW

<sup>[1]</sup> The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

L = LOW voltage level;

X = don't care;

 $<sup>\</sup>uparrow$  = LOW-to-HIGH transition;

 $<sup>\</sup>downarrow$  = HIGH-to-LOW transition;

<sup>[2]</sup>  $P_{tot}$  derates linearly with 12 mW/K above 70 °C.

<sup>[3]</sup> P<sub>tot</sub> derates linearly with 8 mW/K above 70 °C.

<sup>[4]</sup>  $P_{tot}$  derates linearly with 5.5 mW/K above 60 °C.

<sup>[5]</sup> P<sub>tot</sub> derates linearly with 4.5 mW/K above 60 °C.

## 8. Recommended operating conditions

Table 5. Recommended operating conditions

	<u> </u>					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
74HC4017						
V <sub>CC</sub>	supply voltage		2.0	5.0	6.0	V
V <sub>I</sub>	input voltage		0	-	$V_{CC}$	V
Vo	output voltage		0	-	$V_{CC}$	V
Δt/ΔV	input transition rise and fall rate	$V_{CC} = 2.0 \text{ V}$	-	-	625	ns/V
		$V_{CC} = 4.5 \text{ V}$	-	1.67	139	ns/V
		$V_{CC} = 6.0 \text{ V}$	-	-	83	ns/V
T <sub>amb</sub>	ambient temperature		-40	-	+125	°C
74HCT4017						
V <sub>CC</sub>	supply voltage		4.5	5.0	5.5	V
VI	input voltage		0	-	$V_{CC}$	V
Vo	output voltage		0	-	$V_{CC}$	V
Δt/ΔV	input transition rise and fall rate	V <sub>CC</sub> = 4.5 V	-	1.67	139	ns/V
T <sub>amb</sub>	ambient temperature		-40	-	+125	°C

#### 9. Static characteristics

Table 6. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		25 °C		–40 °C to	+85 °C	–40 °C to +125 °C		Unit
				Тур	Max	Min	Max	Min	Max	
74HC40	17					'				
$V_{IH}$	HIGH-level	V <sub>CC</sub> = 2.0 V	1.5	1.2	-	1.5	-	1.5	-	V
	input voltage	V <sub>CC</sub> = 4.5 V	3.15	2.4	-	3.15	-	3.15	-	V
		V <sub>CC</sub> = 6.0 V	4.2	3.2	-	4.2	-	4.2	-	V
$V_{IL}$	V <sub>IL</sub> LOW-level	V <sub>CC</sub> = 2.0 V	-	0.8	0.5	-	0.5	-	0.5	V
	input voltage	V <sub>CC</sub> = 4.5 V	-	2.1	1.35	-	1.35	-	1.35	V
		V <sub>CC</sub> = 6.0 V	-	2.8	1.8	-	1.8	-	1.8	V
$V_{OH}$	HIGH-level	$V_I = V_{IH}$ or $V_{IL}$								
	output voltage	$I_{O} = -20 \mu A; V_{CC} = 2.0 V$	1.9	2.0	-	1.9	-	1.9	-	V
		$I_{O} = -20 \mu A; V_{CC} = 4.5 V$	4.4	4.5	-	4.4	-	4.4	-	V
		$I_{O} = -20 \mu A; V_{CC} = 6.0 V$	5.9	6.0	-	5.9	-	5.9	-	V
		$I_{O} = -4.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	3.98	4.32	-	3.84	-	3.7	-	V
		$I_{O} = -5.2 \text{ mA}; V_{CC} = 6.0 \text{ V}$	5.48	5.81	-	5.34	-	5.2	-	V

**Table 6.** Static characteristics ...continued
At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		25 °C		-40 °C to	o +85 °C	-40 °C to	o +125 °C	Unit
			Min	Тур	Max	Min	Max	Min	Max	
$V_{OL}$	LOW-level	$V_I = V_{IH}$ or $V_{IL}$				ı	ı			
	output voltage	$I_O = 20 \mu A; V_{CC} = 2.0 V$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 20 \mu A; V_{CC} = 4.5 V$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 20 \mu A; V_{CC} = 6.0 V$	-	0	0.1	-	0.1	-	0.1	V
		$I_{O} = 4.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	0.15	0.26	-	0.33	-	0.4	V
		$I_O = 5.2 \text{ mA}; V_{CC} = 6.0 \text{ V}$	-	0.16	0.26	-	0.33	-	0.4	V
l <sub>l</sub>	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 6.0 \text{ V}$	-	-	±0.1	-	±1.0	-	±1.0	μΑ
I <sub>CC</sub>	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 6.0 \text{ V}$	-	-	8.0	-	80	-	160	μΑ
Cı	input capacitance		-	3.5	-	-	-	-	-	pF
74HCT4	017									
$V_{IH}$	HIGH-level input voltage	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	2.0	1.6	-	2.0	-	2.0	-	V
$V_{IL}$	LOW-level input voltage	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	-	1.2	0.8	-	8.0	-	0.8	V
V <sub>OH</sub>	HIGH-level	$V_I = V_{IH}$ or $V_{IL}$ ; $V_{CC} = 4.5 \text{ V}$								
	output voltage	$I_{O} = -20 \mu A$	4.4	4.5	-	4.4	-	4.4	-	V
		$I_O = -4 \text{ mA}$	3.98	4.32	-	3.84	-	3.7	-	V
$V_{OL}$	LOW-level	$V_I = V_{IH}$ or $V_{IL}$ ; $V_{CC} = 4.5 \text{ V}$								
	output voltage	I <sub>O</sub> = 20 μA	-	0	0.1	-	0.1	-	0.1	V
		$I_{O} = 4.0 \text{ mA}$	-	0.15	0.26	-	0.33	-	0.4	V
I <sub>I</sub>	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 5.5 \text{ V}$	-	-	±0.1	-	±1.0	-	±1.0	μΑ
I <sub>CC</sub>	supply current	$V_I = V_{CC}$ or GND; $V_{CC} = 5.5 \text{ V}; I_O = 0 \text{ A}$	-	-	8.0	-	80	-	160	μΑ
Δl <sub>CC</sub>	additional supply current	per input pin; $V_{I} = V_{CC} - 2.1 \text{ V};$ other inputs at $V_{CC}$ or GND; $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V};$ $I_{O} = 0 \text{ A}$								
		CP0 input	-	25	90	-	113	-	123	μΑ
		CP1 input	-	40	144	-	180	-	196	μΑ
		MR input	-	50	180	-	225	-	245	μΑ
C <sub>I</sub>	input capacitance		-	3.5	-	-	-	-	-	pF

## 10. Dynamic characteristics

Table 7. Dynamic characteristics

 $GND = 0 \text{ V; } t_r = t_f = 6 \text{ ns; } C_L = 50 \text{ pF; see } Figure 11.$ 

Symbol	Parameter	Conditions			25 °C		-40 °C t	o +85 °C	-40 °C to	+125 °C	Unit
				Min	Тур	Max	Min	Max	Min	Max	
74HC401	17										'
t <sub>pd</sub>	propagation delay	CP0 to Qn; CP0 to $\overline{Q}$ 5-9; see Figure 10	[1]								
		V <sub>CC</sub> = 2.0 V		-	63	230	-	290	-	345	ns
		V <sub>CC</sub> = 4.5 V		-	23	46	-	58	-	69	ns
		$V_{CC} = 5.0 \text{ V};$ $C_L = 15 \text{ pF}$		-	20	-	-	-	-	-	ns
		$V_{CC} = 6.0 \text{ V}$ $\overline{\text{CP1}}$ to Qn; $\overline{\text{CP1}}$ to $\overline{\text{Q5-9}}$ ; see Figure 10		-	18	39	-	49	-	59	ns
		V <sub>CC</sub> = 2.0 V		-	61	250	-	315	-	375	ns
		V <sub>CC</sub> = 4.5 V		-	22	50	-	63	-	75	ns
		$V_{CC} = 5.0 \text{ V};$ $C_L = 15 \text{ pF}$		-	20	-	-	-	-	-	ns
t <sub>PHL</sub>	HIGH to LOW propagation	V <sub>CC</sub> = 6.0 V MR to Q[1:9]; see <u>Figure 10</u>		-	18	43	-	54	-	64	ns
	delay	V <sub>CC</sub> = 2.0 V		_	52	230	-	290	-	345	ns
		V <sub>CC</sub> = 4.5 V		-	19	46	-	58	-	69	ns
		V <sub>CC</sub> = 6.0 V		-	15	39	-	49	-	59	ns
t <sub>PLH</sub>	LOW to HIGH propagation	MR to Q5-9, Q0; see Figure 10									
	delay	V <sub>CC</sub> = 2.0 V		-	55	230	-	290	-	345	ns
		V <sub>CC</sub> = 4.5 V		-	20	46	-	58	-	69	ns
		$V_{CC} = 6.0 \text{ V}$		-	16	39	-	49	-	59	ns
t <sub>t</sub>	transition time	see Figure 10	[2]								
		V <sub>CC</sub> = 2.0 V		-	19	75	-	95	-	110	ns
		V <sub>CC</sub> = 4.5 V		-	7	15	-	19	-	22	ns
		V <sub>CC</sub> = 6.0 V		-	6	13	-	16	-	19	ns
t <sub>W</sub>	pulse width	CP0 and CP1 (HIGH or LOW); see Figure 9									
		$V_{CC} = 2.0 \text{ V}$		80	17	-	100	-	120	-	ns
		V <sub>CC</sub> = 4.5 V		16	6	-	20	-	24	-	ns
		$V_{CC} = 6.0 \text{ V}$		14	5	-	17	-	20	-	ns
		MR (HIGH); see Figure 9									
		V <sub>CC</sub> = 2.0 V		80	19	-	100	-	120	-	ns
		V <sub>CC</sub> = 4.5 V		16	7	-	20	-	24	-	ns
		$V_{CC} = 6.0 \text{ V}$		14	6	-	17		20		ns

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**Table 7. Dynamic characteristics** ...continued GND = 0 V;  $t_r = t_f = 6$  ns;  $C_l = 50$  pF; see Figure 11.

Symbol	Parameter	Conditions			25 °C		–40 °C to	+85 °C	-40 °C to	+125 °C	Unit
				Min	Тур	Max	Min	Max	Min	Max	
t <sub>su</sub>	set-up time	CP1 to CP0; CP0 to CP1; see Figure 8									
		$V_{CC} = 2.0 \text{ V}$		50	-8	-	65	-	75	-	ns
		$V_{CC} = 4.5 \text{ V}$		10	-3	-	13	-	15	-	ns
		$V_{CC} = 6.0 \text{ V}$		9	-2	-	11	-	13	-	ns
t <sub>h</sub>	hold time	CP1 to CP0; CP0 to CP1; see Figure 8									
		$V_{CC} = 2.0 \text{ V}$		50	17	-	65	-	75	-	ns
		$V_{CC} = 4.5 V$		10	6	-	13	-	15	-	ns
		$V_{CC} = 6.0 \text{ V}$		9	5	-	11	-	13	-	ns
t <sub>rec</sub>	recovery time	MR to <u>CP</u> 0 and MR to <u>CP</u> 1; see <u>Figure 9</u>									
		$V_{CC} = 2.0 \text{ V}$		5	-17	-	5	-	5	-	ns
		$V_{CC} = 4.5 \text{ V}$		5	-6	-	5	-	5	-	ns
		$V_{CC} = 6.0 \text{ V}$		5	-5	-	5	-	5	-	ns
f <sub>max</sub>	maximum	CP0 or CP1; see Figure 9									
	frequency	$V_{CC} = 2.0 \text{ V}$		6.0	23	-	4.8	-	4.0	-	MH
		$V_{CC} = 4.5 \text{ V}$		30	70	-	24	-	20	-	MH
		$V_{CC} = 5.0 \text{ V};$ $C_L = 15 \text{ pF}$		-	77	-	-	-	-	-	MH
		$V_{CC} = 6.0 \text{ V}$		25	83	-	28	-	24	-	MHz
$C_{PD}$	power dissipation capacitance	$V_I = GND \text{ to } V_{CC};$ $V_{CC} = 5 \text{ V}; f_i = 1 \text{ MHz}$	[3]	-	35	-	-	-	-	-	pF
74HCT4	017										
t <sub>pd</sub>	propagation delay	CP0 to Qn; CP0 to $\overline{Q}$ 5-9; see Figure 10	[1]								
		$V_{CC} = 4.5 \text{ V}$		-	25	46	-	58	-	69	ns
		$V_{CC} = 5.0 \text{ V};$ $C_L = 15 \text{ pF}$		-	21	-	-	-	-	-	ns
		$\overline{\text{CP}}$ 1 to Qn; $\overline{\text{CP}}$ 1 to $\overline{\text{Q}}$ 5-9; see Figure 10									
		V <sub>CC</sub> = 4.5 V		-	25	50	-	63	-	75	ns
		$V_{CC} = 5.0 \text{ V};$ $C_L = 15 \text{ pF}$		-	21	-	-	-	-	-	ns
t <sub>PHL</sub>	HIGH to LOW propagation	MR to Q[1:9]; see Figure 10									
	delay	V <sub>CC</sub> = 4.5 V		-	22	46	-	58	-	69	ns
t <sub>PLH</sub>	LOW to HIGH propagation	MR to $\overline{Q}$ 5-9, Q0; see Figure 10									
	delay	V <sub>CC</sub> = 4.5 V		-	20	46	-	58	-	69	ns

**Table 7. Dynamic characteristics** ...continued GND = 0 V;  $t_r = t_f = 6$  ns;  $C_L = 50$  pF; see <u>Figure 11</u>.

Symbol	Parameter	Conditions		25 °C		–40 °C t	o +85 °C	-40 °C to	+125 °C	Unit
			Min	Тур	Max	Min	Max	Min	Max	
t <sub>t</sub>	transition time	see Figure 10 [2]				1				
		$V_{CC} = 4.5 \text{ V}$	-	7	15	-	19	-	22	ns
t <sub>W</sub> pulse width		CP0 and CP1 (HIGH or LOW); see Figure 9								
		$V_{CC} = 4.5 \text{ V}$	16	7	-	20	-	24	-	ns
		MR (HIGH); see Figure 9								
		$V_{CC} = 4.5 \text{ V}$	16	4	-	20	-	24	-	ns
t <sub>su</sub>	set-up time	CP1 to CP0; CP0 to CP1; see Figure 8								
		$V_{CC} = 4.5 \text{ V}$	10	-3	-	13	-	15	-	ns
t <sub>h</sub>	hold time	CP1 to CP0; CP0 to CP1; see Figure 8								
		$V_{CC} = 4.5 \text{ V}$	10	6	-	13	-	15	-	ns
t <sub>rec</sub>	recovery time	MR to <u>CP</u> 0 and MR to <u>CP</u> 1; see <u>Figure 9</u>								
		$V_{CC} = 4.5 \text{ V}$	5	-5	-	5	-	5	-	ns
f <sub>max</sub>	maximum	CP0 or CP1; see Figure 9								
	frequency	$V_{CC} = 4.5 \text{ V}$	30	61	-	24	-	20	-	MHz
		$V_{CC} = 5.0 \text{ V};$ $C_L = 15 \text{ pF}$	-	67	-	-	-	-	-	MHz
C <sub>PD</sub>	power dissipation capacitance	$V_{I} = GND \text{ to } V_{CC} - 1.5 \text{ V};$ $V_{CC} = 5 \text{ V}; f_{i} = 1 \text{ MHz}$		36	-	-	-	-	-	pF

<sup>[1]</sup>  $t_{pd}$  is the same as  $t_{PHL}$  and  $t_{PLH}$ .

 $P_D = C_{PD} \times V_{CC}{}^2 \times f_i \times N + \sum (C_L \times V_{CC}{}^2 \times f_o)$  where:

 $f_i$  = input frequency in MHz;

 $f_0$  = output frequency in MHz;

C<sub>L</sub> = output load capacitance in pF;

 $V_{CC}$  = supply voltage in V;

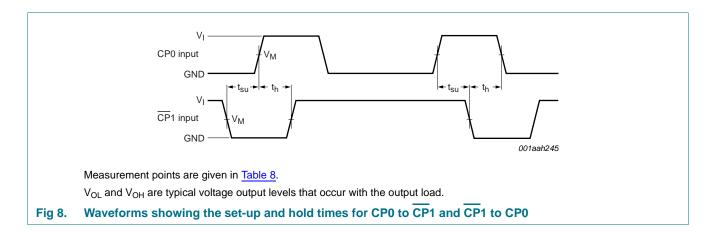
N = number of inputs switching;

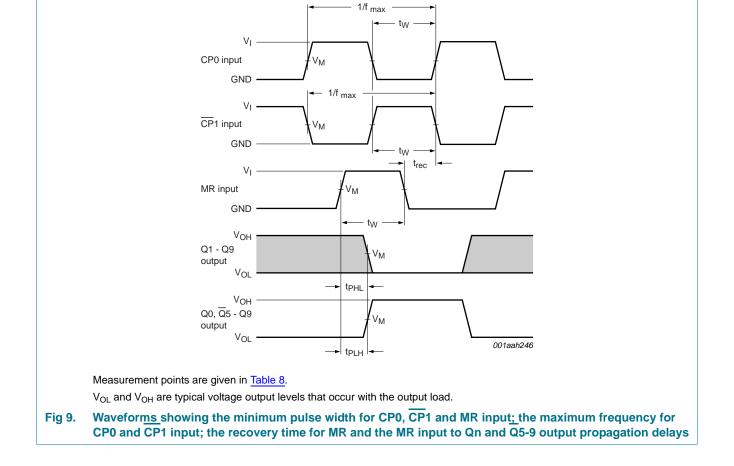
 $\sum (C_L \times V_{CC}^2 \times f_o) = \text{sum of outputs.}$ 

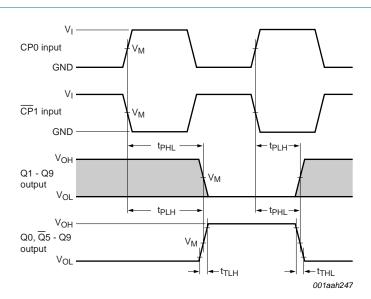
<sup>[2]</sup>  $t_t$  is the same as  $t_{THL}$  and  $t_{TLH}$ .

<sup>[3]</sup>  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu W$ ):

#### 11. Waveforms







Measurement points are given in Table 8.

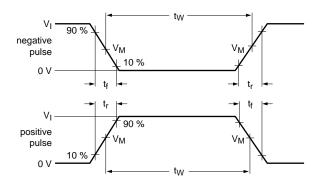
 $V_{\text{OL}}$  and  $V_{\text{OH}}$  are typical voltage output levels that occur with the output load.

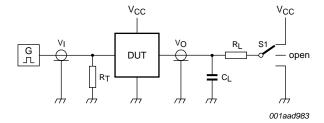
Conditions:  $\overline{\text{CP}1} = \text{LOW}$  while CP0 is triggered on a LOW-to-HIGH transition and CP0 = HIGH, while  $\overline{\text{CP}1}$  is triggered on a HIGH-to-LOW transition.

Fig 10. Waveforms showing the propagation delays for CP0,  $\overline{\text{CP}}1$  to Qn,  $\overline{\text{Q}}5$ -9 outputs and the output transition times

Table 8. Measurement points

Туре	Input	Output
	V <sub>M</sub>	V <sub>M</sub>
74HC4017	0.5 × V <sub>CC</sub>	$0.5 \times V_{CC}$
74HCT4017	1.3 V	1.3 V





Test data is given in Table 9.

Definitions test circuit:

 $R_T$  = Termination resistance should be equal to output impedance  $Z_0$  of the pulse generator.

C<sub>L</sub> = Load capacitance including jig and probe capacitance.

R<sub>L</sub> = Load resistance.

S1 = Test selection switch.

Fig 11. Load circuitry for measuring switching times

Table 9. Test data

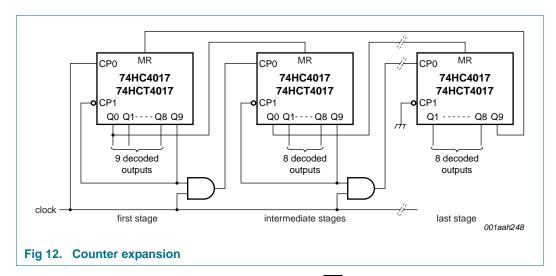
Туре	Input		Load	Load		S1 position			
	VI	t <sub>r</sub> , t <sub>f</sub>	C <sub>L</sub>	R <sub>L</sub>	t <sub>PHL</sub> , t <sub>PLH</sub>	t <sub>PZH</sub> , t <sub>PHZ</sub>	t <sub>PZL</sub> , t <sub>PLZ</sub>		
74HC4017	$V_{CC}$	6 ns	15 pF, 50 pF	1 kΩ	open	GND	V <sub>CC</sub>		
74HCT4017	3 V	6 ns	15 pF, 50 pF	1 kΩ	open	GND	$V_{CC}$		

## 12. Application information

Some examples of applications for the 74HC4017; 74HCT4017 are:

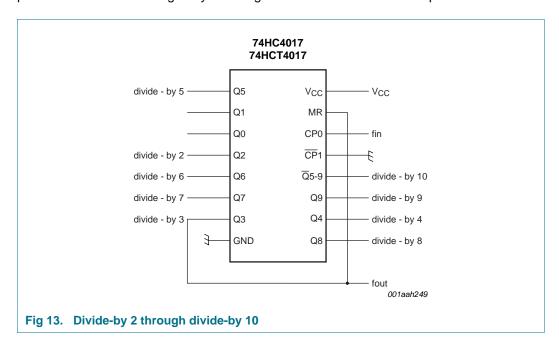
- · Decade counter with decimal decoding
- 1 out of n decoding counter (when cascaded)
- Sequential controller
- Timer

<u>Figure 12</u> shows a technique for extending the number of decoded output states for the 74HC4017; 74HCT4017. Decoded outputs are sequential within each stage and from stage to stage, with no dead time (except propagation delay).



**Remark:** It is essential not to enable the counter on  $\overline{CP1}$  when CP0 is HIGH, or on CP0 when  $\overline{CP1}$  is LOW, as this would cause an extra count.

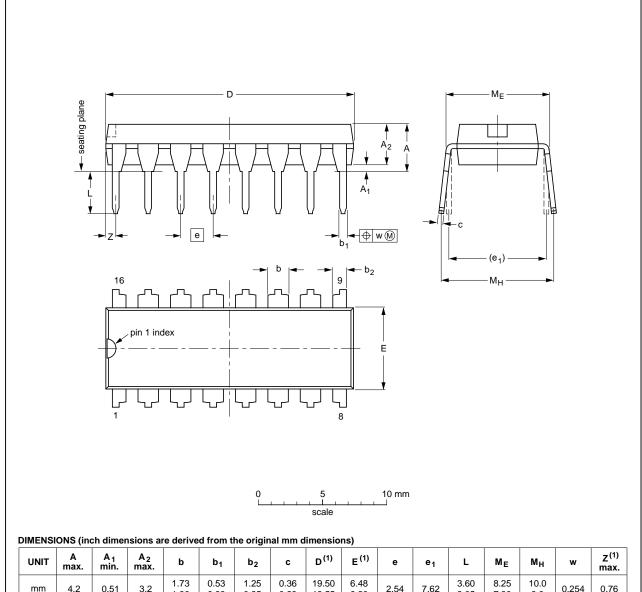
Figure 13 shows an example of a divide-by 2 through divide-by 10 circuit using one 74HC4017; 74HCT4017. Since the 74HC4017; 74HCT4017 has an asynchronous reset, the output pulse widths are narrow (minimum expected pulse width is 6 ns). The output pulse widths can be enlarged by inserting an RC network at the MR input.



## 13. Package outline

#### DIP16: plastic dual in-line package; 16 leads (300 mil)

SOT38-4



UNIT	A max.	A <sub>1</sub> min.	A <sub>2</sub> max.	b	b <sub>1</sub>	b <sub>2</sub>	С	D <sup>(1)</sup>	E <sup>(1)</sup>	е	e <sub>1</sub>	L	ME	Мн	w	Z <sup>(1)</sup> max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	1.25 0.85	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	0.76
inches	0.17	0.02	0.13	0.068 0.051	0.021 0.015	0.049 0.033	0.014 0.009	0.77 0.73	0.26 0.24	0.1	0.3	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.03

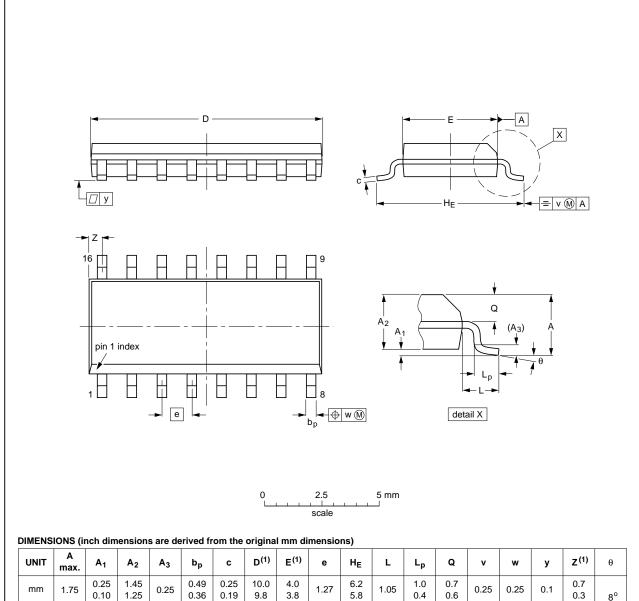
1. Plastic or metal protrusions of 0.25 mm (0.01 inch) maximum per side are not included.

OUTLINE		REFERENCES EUROPEAN 15						
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE		
SOT38-4						<del>95-01-14</del> 03-02-13		

Fig 14. Package outline SOT38-4 (DIP16)

#### SO16: plastic small outline package; 16 leads; body width 3.9 mm

SOT109-1



UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	С	D <sup>(1)</sup>	E <sup>(1)</sup>	е	HE	L	Lp	ø	v	w	у	Z <sup>(1)</sup>	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	10.0 9.8	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
inches	0.069	0.010 0.004	0.057 0.049	0.01		0.0100 0.0075		0.16 0.15	0.05	0.244 0.228	0.041	0.039 0.016		0.01	0.01	0.004	0.028 0.012	0°

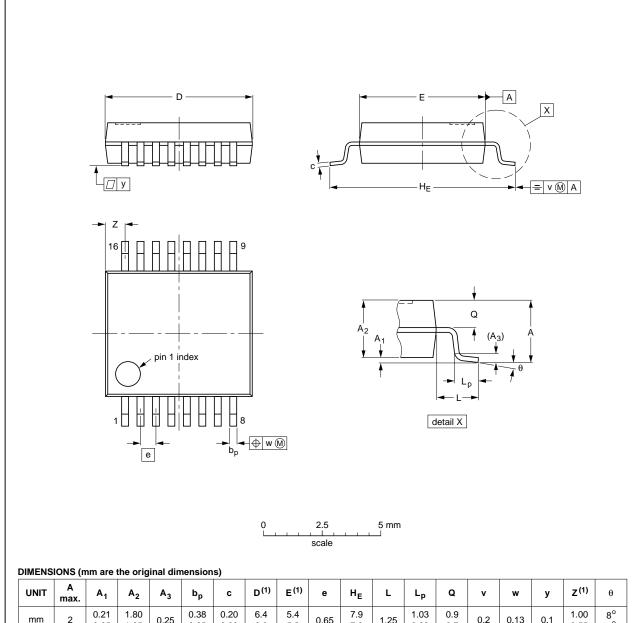
1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

	REFER	EUROPEAN	ISSUE DATE			
IEC	JEDEC	JEITA		PROJECTION	1330E DATE	
076E07	MS-012				<del>99-12-27</del> 03-02-19	
		IEC JEDEC		IEC JEDEC JEITA	IEC JEDEC JEITA PROJECTION	

Fig 15. Package outline SOT109-1 (SO16)

SSOP16: plastic shrink small outline package; 16 leads; body width 5.3 mm

SOT338-1



UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	b <sub>p</sub>	U	D <sup>(1)</sup>	E <sup>(1)</sup>	e	HE	L	Lp	Q	v	w	у	Z <sup>(1)</sup>	θ
mm	2	0.21 0.05	1.80 1.65	0.25	0.38 0.25	0.20 0.09	6.4 6.0	5.4 5.2	0.65	7.9 7.6	1.25	1.03 0.63	0.9 0.7	0.2	0.13	0.1	1.00 0.55	8° 0°

#### Note

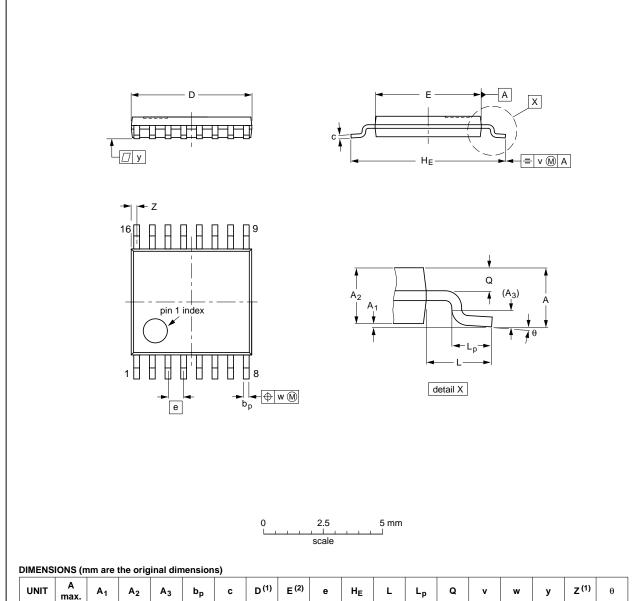
1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT338-1		MO-150				<del>99-12-27</del> 03-02-19

Fig 16. Package outline SOT338-1 (SSOP16)

TSSOP16: plastic thin shrink small outline package; 16 leads; body width 4.4 mm

SOT403-1



-							-,												
	UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	С	D <sup>(1)</sup>	E <sup>(2)</sup>	е	HE	L	Lp	Q	v	w	у	Z <sup>(1)</sup>	θ
	mm	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	5.1 4.9	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.40 0.06	8° 0°

#### Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT403-1		MO-153				<del>-99-12-27</del> 03-02-18	
					7	03-02-10	

Fig 17. Package outline SOT403-1 (TSSOP16)

74HC\_HCT4017

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DHVQFN16: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 16 terminals; body 2.5 x 3.5 x 0.85 mm SOT763-1

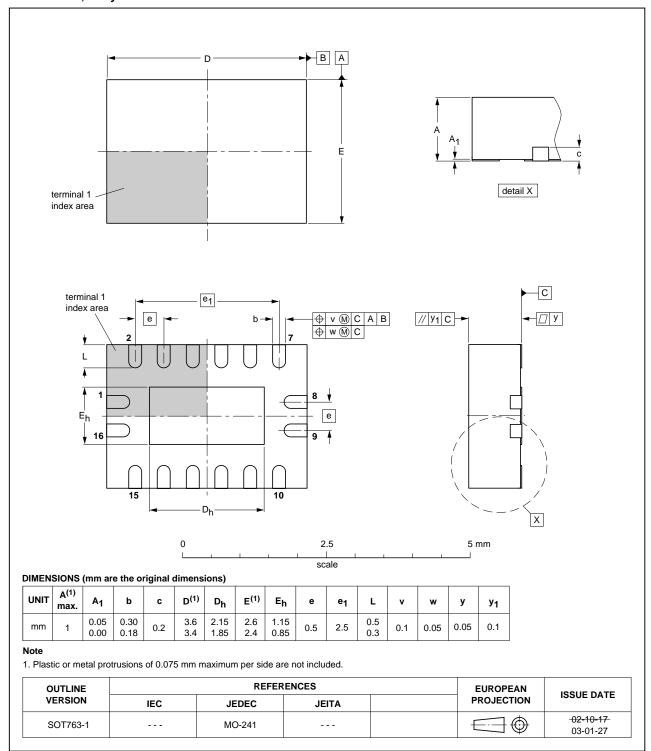


Fig 18. Package outline SOT763-1 (DHVQFN16)

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## 14. Abbreviations

#### Table 10. Abbreviations

Acronym	Description
CMOS	Complementary Metal Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
НВМ	Human Body Model
MM	Machine Model
TTL	Transistor-Transistor Logic

## 15. Revision history

#### Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74HC_HCT4017 v.4	20131210	Product data sheet	-	74HC_HCT4017 v.3
Modifications:	General de	escription updated.		
74HC_HCT4017 v.3	20080108	Product data sheet	-	74HC_HCT4017_CNV v.2
Modifications:		of this data sheet has be of NXP Semiconductors.	en redesigned to co	mply with the new identity
	<ul> <li>Legal texts</li> </ul>	have been adapted to the	e new company nam	ne where appropriate.
	• Section 3:	DHVQFN16 package add	ed.	
	• Section 7:	derating values added for	DHVQFN16 packag	je.
	Section 13:	: outline drawing added fo	or DHVQFN16 packa	ige.
74HC_HCT4017_CNV v.2	19970829	Product specification	-	-

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Document status[1][2]	Product status[3]	Definition
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Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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